## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Osamu Hikita et al.

Serial No.:

**TBD** 

Filing Date:

Herewith

Title:

ELECTROMAGNETIC WAVE SHIELDING WINDOW, MANUFACTURING

APPARATUS HAVING THE SAME, TRANSPORT SYSTEM HAVING THE

SAME, BUILDING CONSTRUCTION HAVING THE SAME, AND ELECTROMAGNETIC WAVE SHIELDING METHOD

Docket No.:

36607

## **INFORMATION DISCLOSURE STATEMENT**

Mail Stop PATENT APPLICATION Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with Rule 56, applicants are aware of the publications listed in the enclosed copy of Patent Office Form 1449. A copy of each of the publications is enclosed herewith. Also enclosed is a copy of an International Search Report from a counterpart application.

Respectfully submitted,

PEARNE & GORDON/LLP

By:

Michael W. Garvey, Reg. No. 35878

1801 East 9th Street Suite 1200 Cleveland, Ohio 44114-3108 (216) 579-1700

Date: March 25, 2004

Form PTO-1449

## U.S. DEPARTMENT OF COMMERCE

## PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE CITATION BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)

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U.S. PATENT DOCUMENTS												
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		Document No.	Date	Countr	<u>у</u>	Clas	s	Subclass			Translation	
	I	0 277 818 A2	08/1988	EP					Er		nglish text/ Cited on ISR	
	J	3-131094 A	06/1991	JР							Cited on ISR	
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